Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,103	CHEN ET AL.	_
Examiner	Art Unit	
Robert DeBeradinis	2836	

	SEAR	CHED	
Class	Subclass	Date	Examiner
307	82	9/11/2006	RLD

INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARC (INCLUDING SE	CH NOTES ARCH STRATEGY)
	DATE	EXMR
EXT SEARCH	9/11/2006	RLD